Docket No.: Q137-US6

### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re Application of:

SKINLO, David M. : Examiner: N/A : Art Unit: N/A

Serial No.: N/A

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Filed: September 17, 2003

For: ELECTRIC STORAGE BATTERY

CONSTRUCTION AND METHOD

OF MANUFACTURE

Mail Stop Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

This information disclosure statement and Substitute Form 1449 submitted herewith is being filed within three (3) months of the filing date of a national application and before a first action on the merits for the subject application. Copies of the references cited on the Substitute Form 1449 are not enclosed as they have previously been provided in the parent application, U.S. Application No. 10/167,688, filed June 12, 2002.

If it should be determined that for any reason either an insufficient or excessive fee has been paid, please charge any insufficiency or credit any overpayment necessary to ensure consideration of the information disclosure statement for the above-identified application to Deposit Account No. 50-0921. A copy of this paper is enclosed.

Respectfully submitted:

Dated: 9-17-03

M. Elizabeth Bush Reg. No. 38,402

Patent Agent for Applicant(s)

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# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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	Application Number	N/A				
	Filing Date	September 17, 2003				
	First Named Inventor	David M. Skinlo				
	Art Unit	N/A				
	Examiner Name	N/A				
	Attorney Docket number	Q137-US6				

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Signature	Considered	

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